SM4603CSK

Dual Enhancement Mode MOSFET (N-and P-Channel)

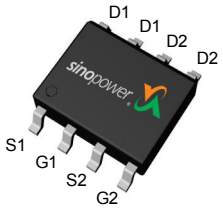
Features

- **N Channel**
  30V/8.7A,
  $R_{DS(ON)}$ = 21mΩ (max.) @ V_{GS} = 10V
  $R_{DS(ON)}$ = 30mΩ (max.) @ V_{GS} = 4.5V
- **P Channel**
  -30V/-8.2A,
  $R_{DS(ON)}$ = 24mΩ (max.) @ V_{GS} =-10V
  $R_{DS(ON)}$ = 38mΩ (max.) @ V_{GS} =-4.5V
- 100% UIS Tested
- Reliable and Rugged
- Lead Free Available (RoHS Compliant)

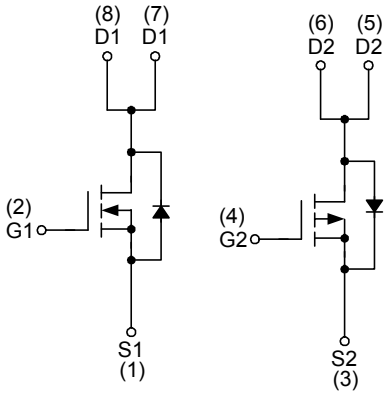
Applications

- Synchronous Rectification.
- Motor Control
- High Current, High Speed Switching

Pin Description



Top View of SOP – 8



N-Channel MOSFET P-Channel MOSFET

Ordering and Marking Information

SM4603CS □□-□□ □ Assembly Material Handling Code Temperature Range Package Code	Package Code K : SOP-8 Operating Junction Temperature Range C : -55 to 175 °C Handling Code TR : Tape & Reel (2500ea/reel) Assembly Material G : Halogen and Lead Free Device
SM4603CS K : 	XXXXX - Lot Code

Note : SINOPOWER lead-free products contain molding compounds/die attach materials and 100% matte tin plate termination finish; which are fully compliant with RoHS. SINOPOWER lead-free products meet or exceed the lead-free requirements of IPC/JEDEC J-STD-020D for MSL classification at lead-free peak reflow temperature. SINOPOWER defines "Green" to mean lead-free (RoHS compliant) and halogen free (Br or Cl does not exceed 900ppm by weight in homogeneous material and total of Br and Cl does not exceed 1500ppm by weight).

Absolute Maximum Ratings (T_A = 25°C unless otherwise noted)

Symbol	Parameter		N Channel	P Channel	Unit
Common Ratings					
V_{DSS}	Drain-Source Voltage		30	-30	V
V_{GSS}	Gate-Source Voltage		±20	±20	V
T_J	Maximum Junction Temperature		175		°C
T_{STG}	Storage Temperature Range		-55 to 175		°C
I_S	Diode Continuous Forward Current		2	-2	A
I_{DP}	300µs Pulse Drain Current Tested	V_{GS}=10V(N),V_{GS}=-10V(P)	32	-32	A
I_D	Continuous Drain Current	T_A=25°C	8.7	-8.2	A
		T_A=70°C	7.3	-6.8	
P_D	Maximum Power Dissipation	T_A=25°C	2.4	2.4	W
		T_A=70°C	1.7	1.7	
$R_{\theta JL}$	Thermal Resistance-Junction to Lead	Steady State	50	50	°C/W
$R_{\theta JA}$	Thermal Resistance-Junction to Ambient	t ≤ 10s	62.5	62.5	°C/W
		Steady State	110	110	
I_{AS} [a]	Avalanche Current, Single pulse (L=0.5mH)		7.2	12	A
E_{AS} [a]	Avalanche Energy, Single pulse (L=0.5mH)		12	36	mJ

Note a : UIS tested and pulse width limited by maximum junction temperature 150°C (initial temperature T_j=25°C).

N Channel Electrical Characteristics (T_A = 25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	N Channel			Unit
			Min.	Typ.	Max.	
Static Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	V_{GS}=0V, I_{DS}=250μA	30	-	-	V
I_{DSS}	Zero Gate Voltage Drain Current	V_{DS}=24V, V_{GS}=0V	-	-	1	μA
		T_J=85°C	-	-	30	
$V_{GS(th)}$	Gate Threshold Voltage	V_{DS}=V_{GS}, I_{DS}=250μA	1.5	1.8	2.5	V
I_{GSS}	Gate Leakage Current	V_{GS}=±20V, V_{DS}=0V	-	-	±100	nA
$R_{DS(ON)}$ [b]	Drain-Source On-state Resistance	V_{GS}=10V, I_{DS}=8A	-	17	21	mΩ
		V_{GS}=4.5V, I_{DS}=5A	-	23	30	
Diode Characteristics						
V_{SD} [b]	Diode Forward Voltage	I_{SD}=1A, V_{GS}=0V	-	0.75	1.1	V
t_{rr}	Reverse Recovery Time	I_{DS}=8A, dI_{SD}/dt=100A/μs	-	12	-	ns
Q_{rr}	Reverse Recovery Charge		-	3.5	-	nC
Dynamic Characteristics [c]						
R_G	Gate Resistance	V_{GS}=0V,V_{DS}=0V,F=1MHz	-	1.5	-	Ω
C_{iss}	Input Capacitance	V_{GS}=0V, V_{DS}=15V, Frequency=1.0MHz	-	410	-	pF
C_{oss}	Output Capacitance		-	70	-	
C_{rss}	Reverse Transfer Capacitance		-	40	-	
$t_{d(ON)}$	Turn-on Delay Time	V_{DD}=15V, R_L=15Ω, I_{DS}=1A, V_{GEN}=10V, R_G=6Ω	-	5.2	-	ns
t_r	Turn-on Rise Time		-	8.6	-	
$t_{d(OFF)}$	Turn-off Delay Time		-	13.5	-	
t_f	Turn-off Fall Time		-	3.4	-	
Gate Charge Characteristics [c]						
Q_g	Total Gate Charge	V_{DS}=15V, V_{GS}=10V, I_{DS}=8A	-	8.1	13	nC
Q_g	Total Gate Charge	V_{DS}=15V, V_{GS}=4.5V, I_{DS}=8A	-	3.9	5.5	
Q_{gth}	Threshold Gate Charge		-	0.73	-	
Q_{gs}	Gate-Source Charge		-	1.5	-	
Q_{gd}	Gate-Drain Charge		-	1.6	-	

Note b：Pulse test ; pulse width≤300μs, duty cycle≤2%.

c：Guaranteed by design, not subject to production testing.

P Channel Electrical Characteristics (T_A = 25°C unless otherwise noted)

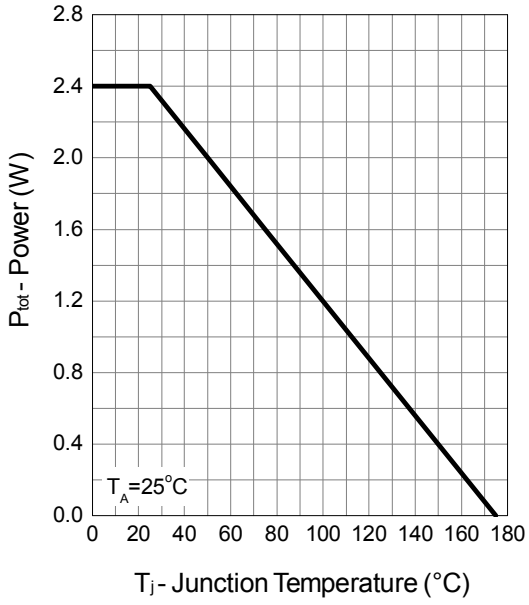
Symbol	Parameter	Test Conditions	P Channel			Unit
			Min.	Typ.	Max.	
Static Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	V_{GS}=0V, I_{DS}=-250μA	-30	-	-	V
I_{DSS}	Zero Gate Voltage Drain Current	V_{DS}=-24V, V_{GS}=0V	-	-	-1	μA
		T_J=85°C	-	-	-30	mA
$V_{GS(th)}$	Gate Threshold Voltage	V_{DS}=V_{GS}, I_{DS}=-250μA	-1.3	-1.8	-2.3	V
I_{GSS}	Gate Leakage Current	V_{GS}=±20V, V_{DS}=0V	-	-	±100	nA
$R_{DS(ON)}$ [b]	Drain-Source On-state Resistance	V_{GS}=-10V, I_{DS}=-7.5A	-	20	24	mΩ
		V_{GS}=-4.5V, I_{DS}=-4A	-	30	38	
Diode Characteristics						
V_{SD} [b]	Diode Forward Voltage	I_{SD}=-1A, V_{GS}=0V	-	-0.75	-1	V
t_{rr}	Reverse Recovery Time	I_{DS}=-7.5A, dI_{SD}/dt=100A/μs	-	18	-	ns
Q_{rr}	Reverse Recovery Charge		-	9	-	nC
Dynamic Characteristics [c]						
R_G	Gate Resistance	V_{GS}=0V,V_{DS}=0V,F=1MHz	-	7	-	Ω
C_{iss}	Input Capacitance	V_{GS}=0V, V_{DS}=-15V, Frequency=1.0MHz	-	840	-	pF
C_{oss}	Output Capacitance		-	150	-	
C_{rss}	Reverse Transfer Capacitance		-	110	-	
$t_{d(ON)}$	Turn-on Delay Time	V_{DD}=-15V, R_L=15Ω, I_{DS}=-1A, V_{GEN}=-10V, R_G=6Ω	-	7.5	-	ns
t_r	Turn-on Rise Time		-	8	-	
$t_{d(OFF)}$	Turn-off Delay Time		-	37	-	
t_f	Turn-off Fall Time		-	16	-	
Gate Charge Characteristics [c]						
Q_g	Total Gate Charge	V_{DS}=-15V, V_{GS}=-10V, I_{DS}=-7.5A	-	18	-	nC
Q_g	Total Gate Charge	V_{DS}=-15V, V_{GS}=-4.5V, I_{DS}=-7.5A	-	8.5	-	
Q_{gth}	Threshold Gate Charge		-	1.6	-	
Q_{gs}	Gate-Source Charge		-	3	-	
Q_{gd}	Gate-Drain Charge		-	4	-	

Note b：Pulse test; pulse width≤300μs, duty cycle≤2%.

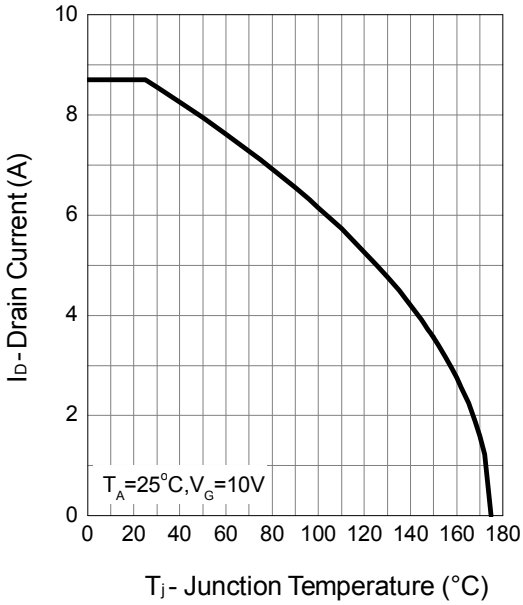
c：Guaranteed by design, not subject to production testing.

N Channel Typical Operating Characteristics

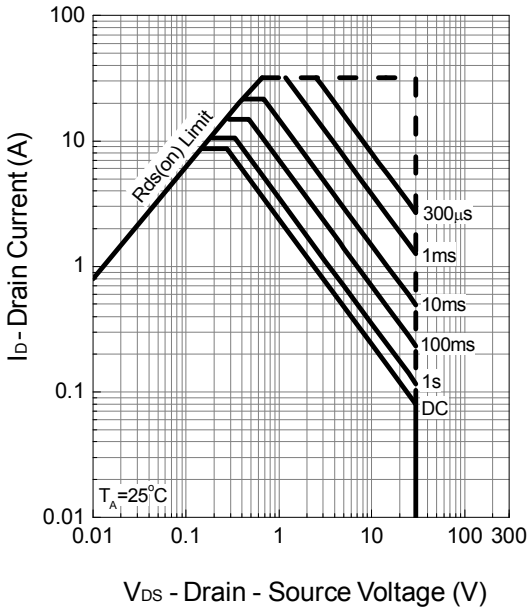
Power Dissipation



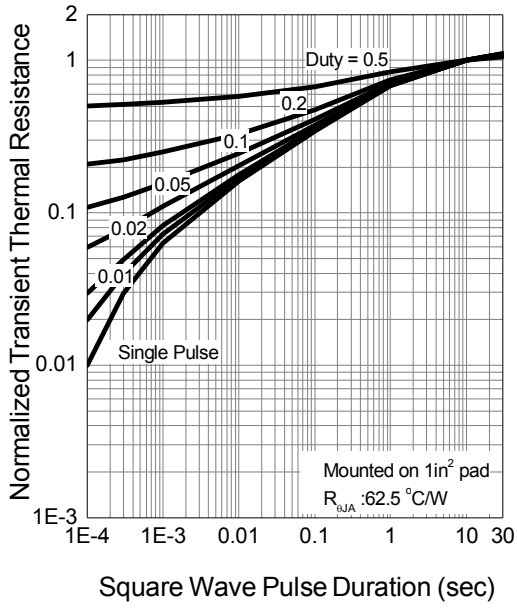
Drain Current



Safe Operation Area

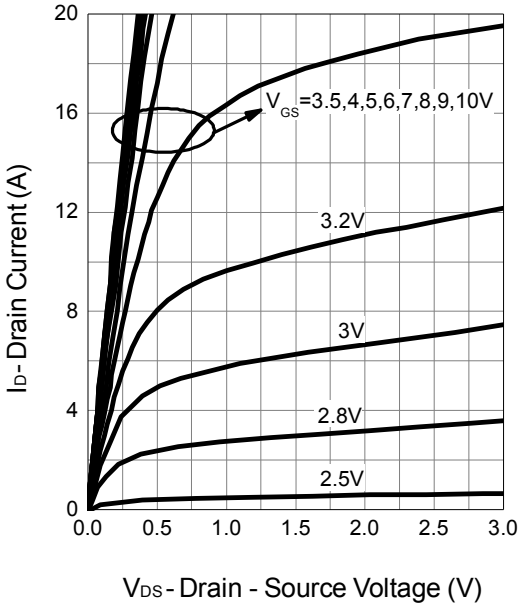


Thermal Transient Impedance

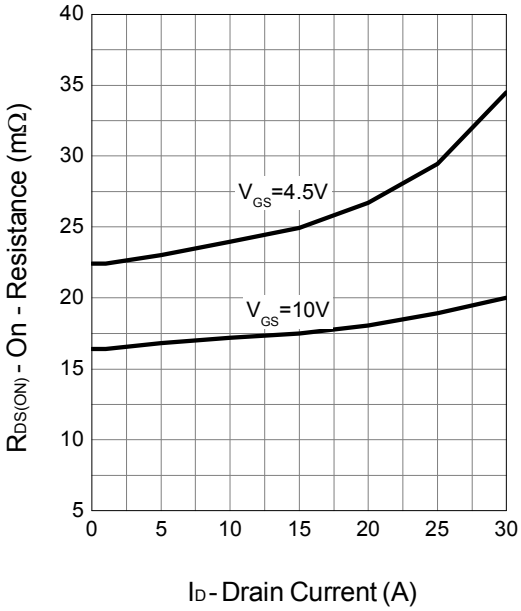


N Channel Typical Operating Characteristics (Cont.)

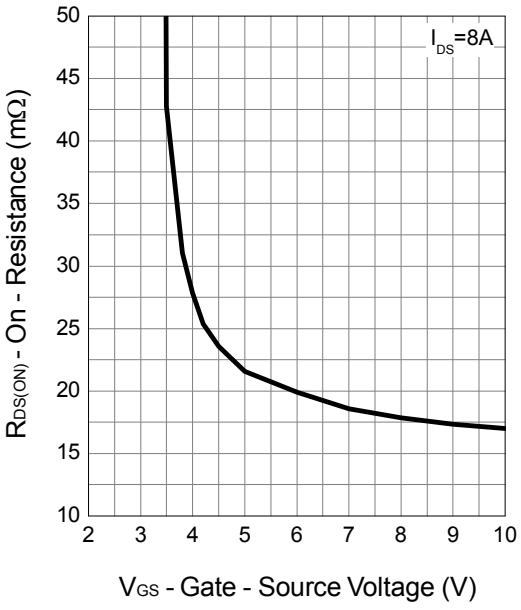
Output Characteristics



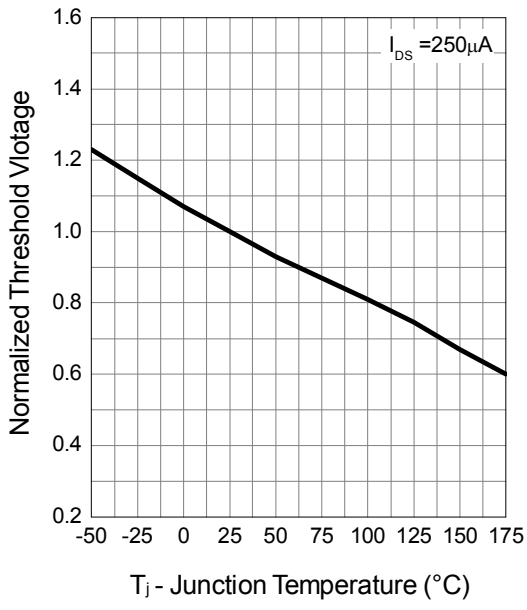
Drain-Source On Resistance



Gate-Source On Resistance

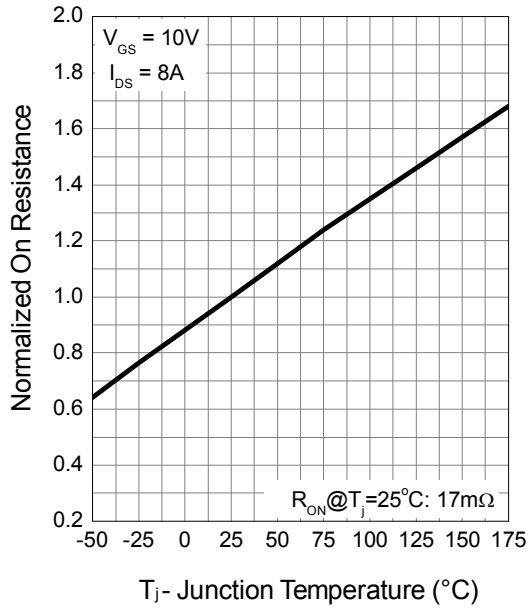


Gate Threshold Voltage

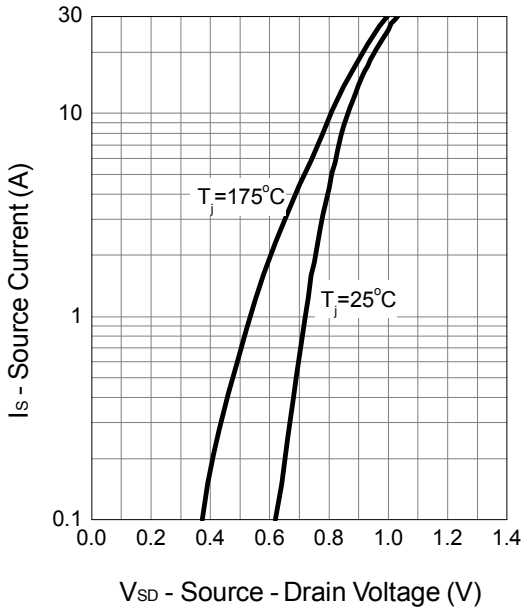


N Channel Typical Operating Characteristics (Cont.)

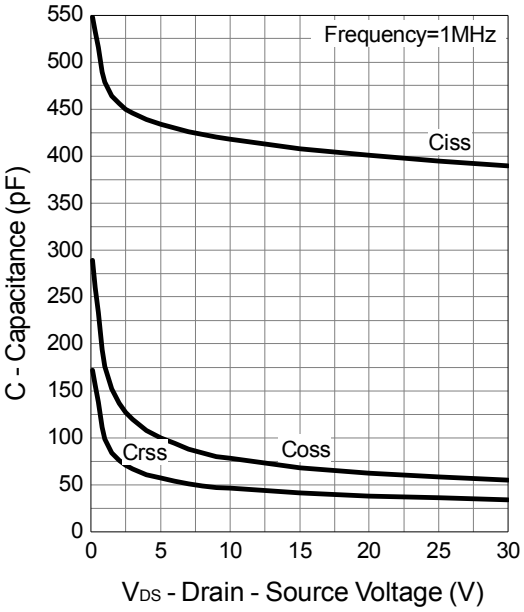
Drain-Source On Resistance



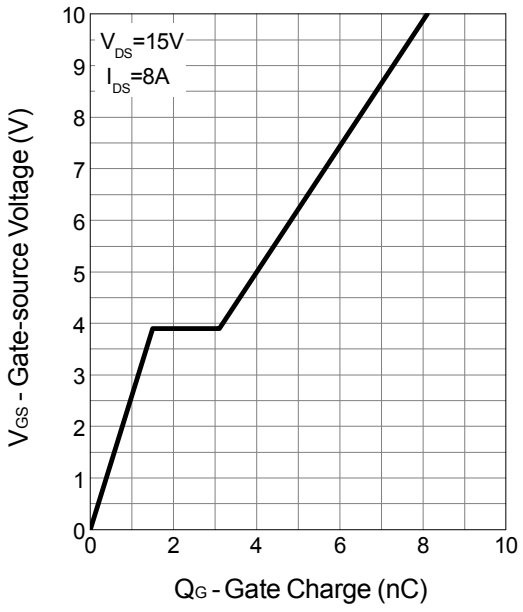
Source-Drain Diode Forward



Capacitance

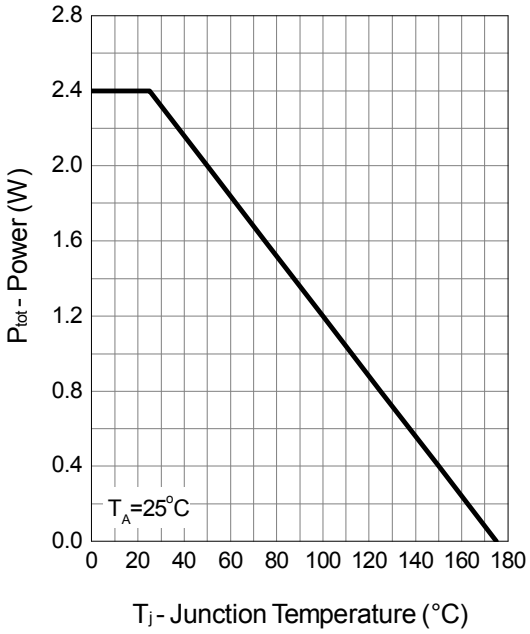


Gate Charge

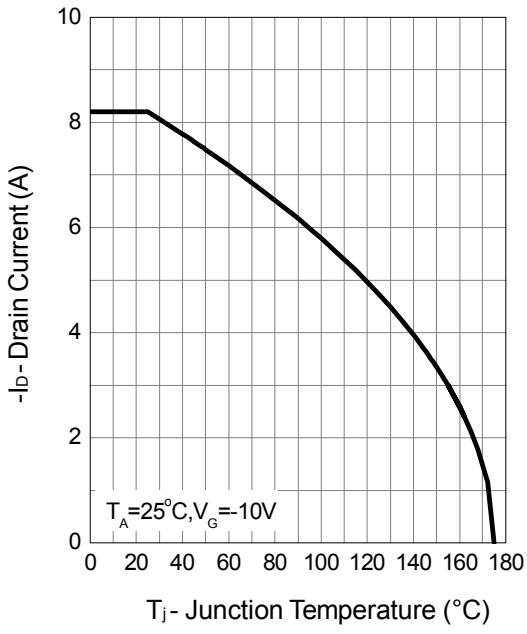


P Channel Typical Operating Characteristics

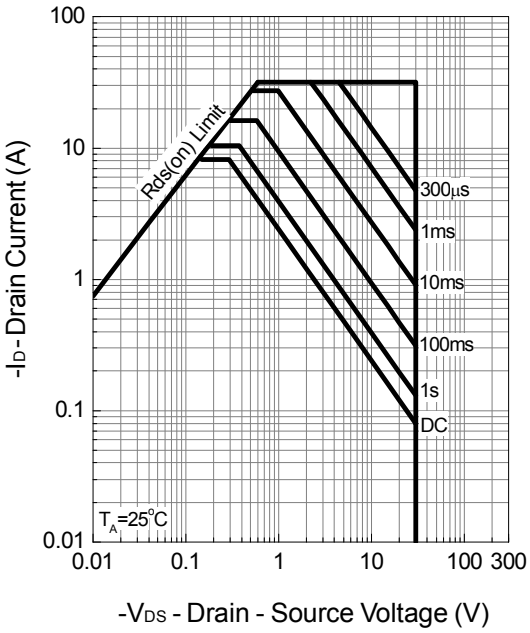
Power Dissipation



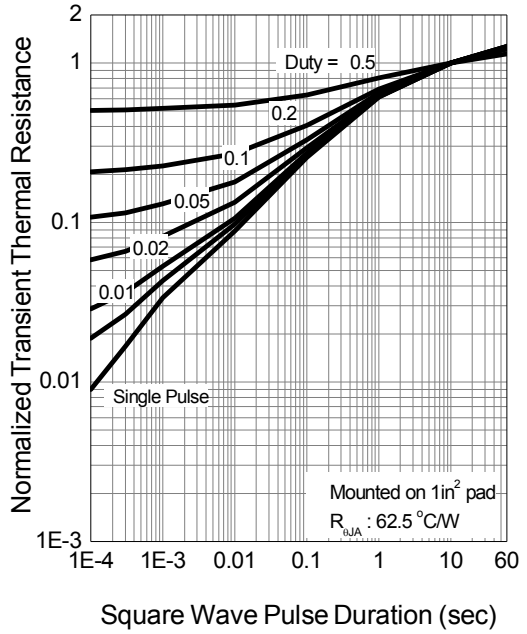
Drain Current



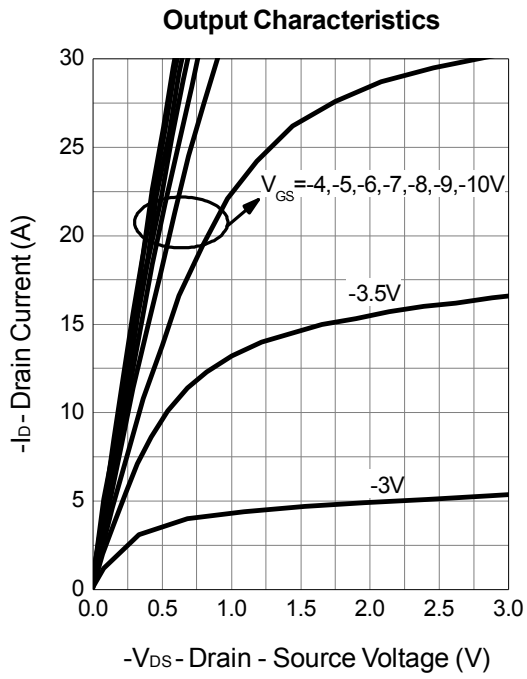
Safe Operation Area

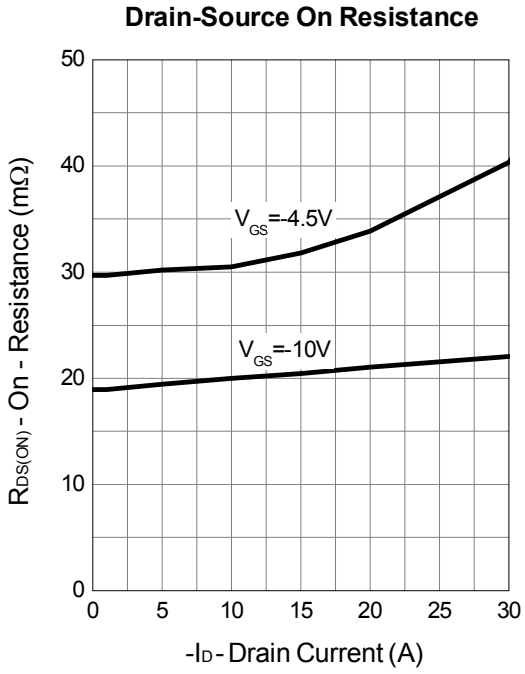


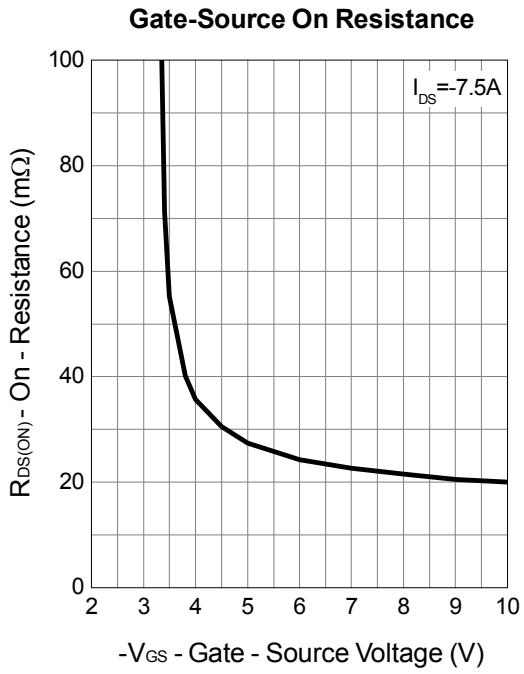
Thermal Transient Impedance

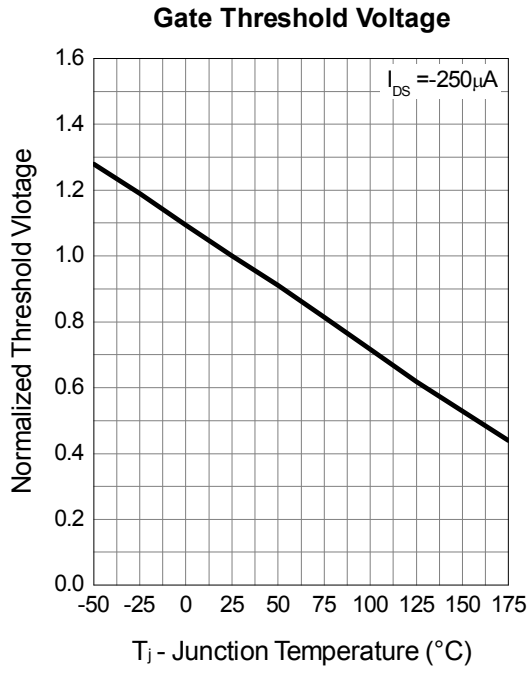


P Channel Typical Operating Characteristics (Cont.)



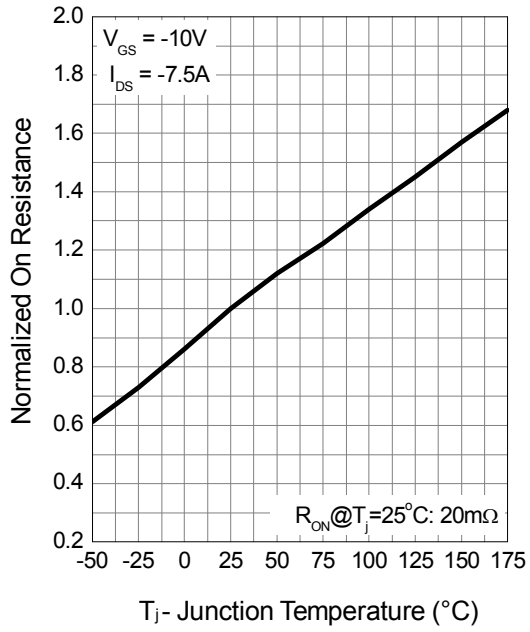




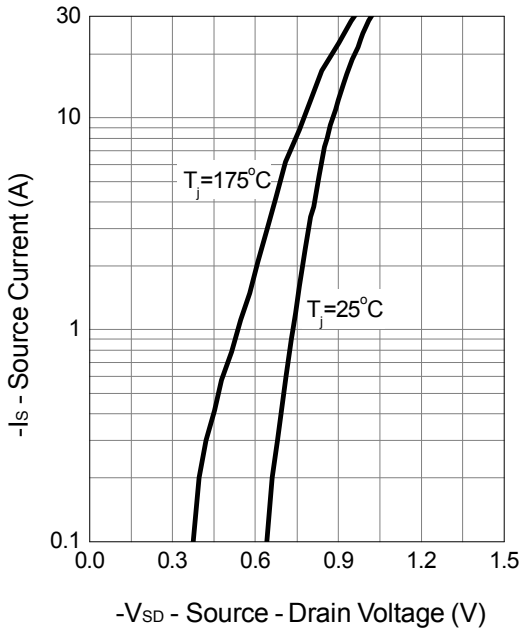


P Channel Typical Operating Characteristics (Cont.)

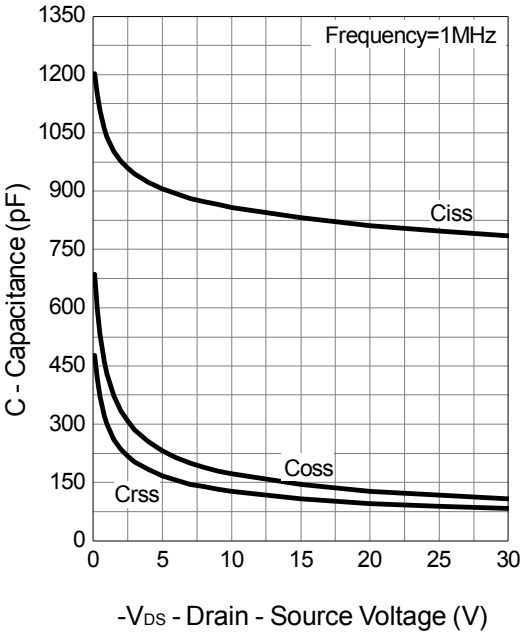
Drain-Source On Resistance



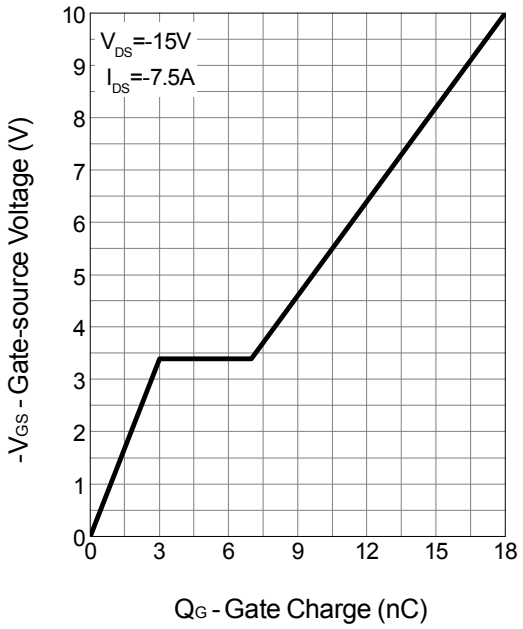
Source-Drain Diode Forward



Capacitance

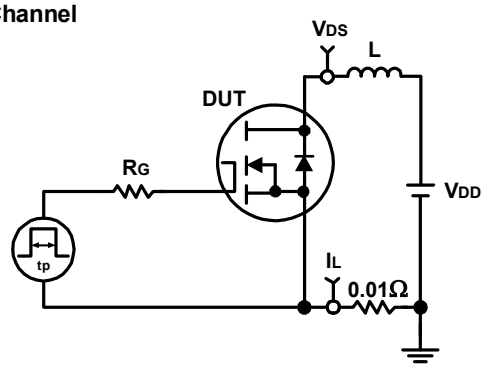


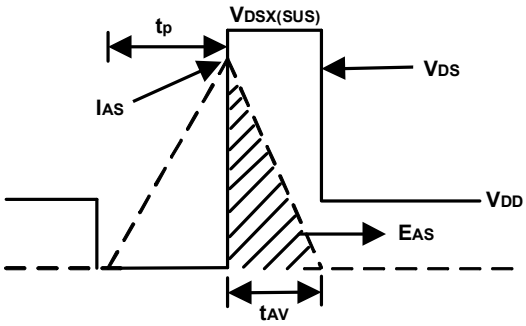
Gate Charge



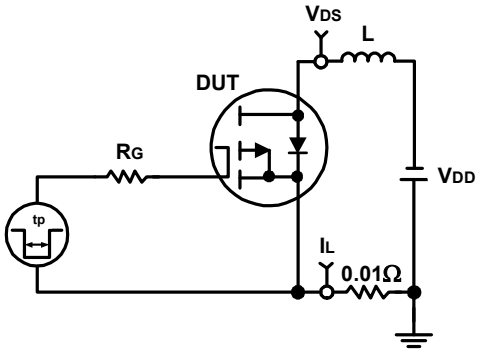
Avalanche Test Circuit and Waveforms

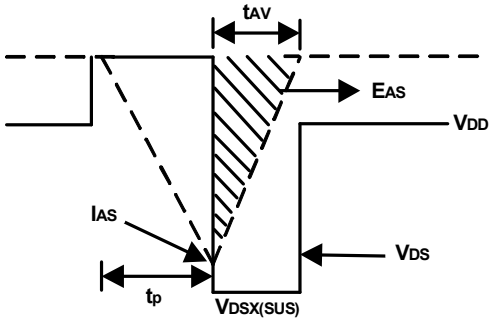
N Channel





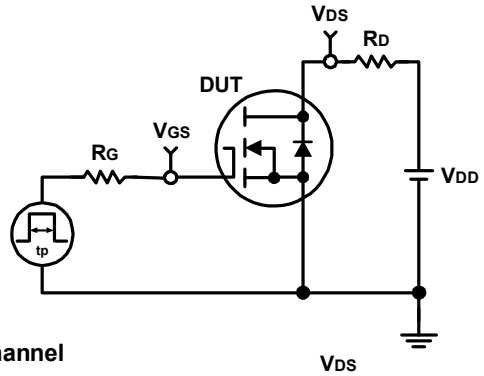
P Channel

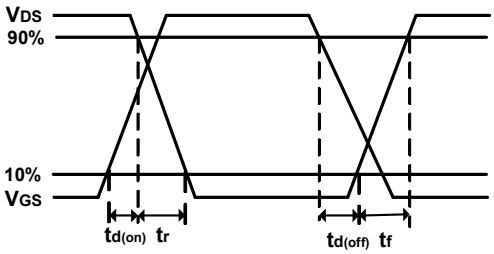




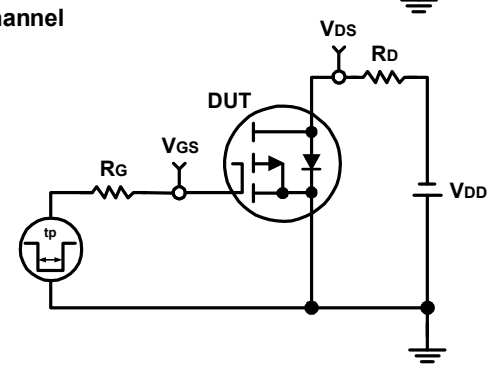
Switching Time Test Circuit and Waveforms

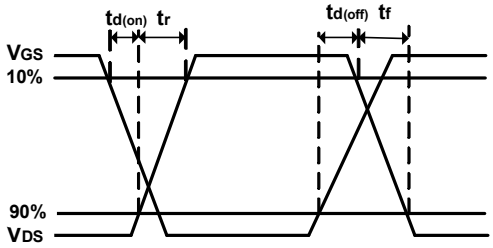
N Channel





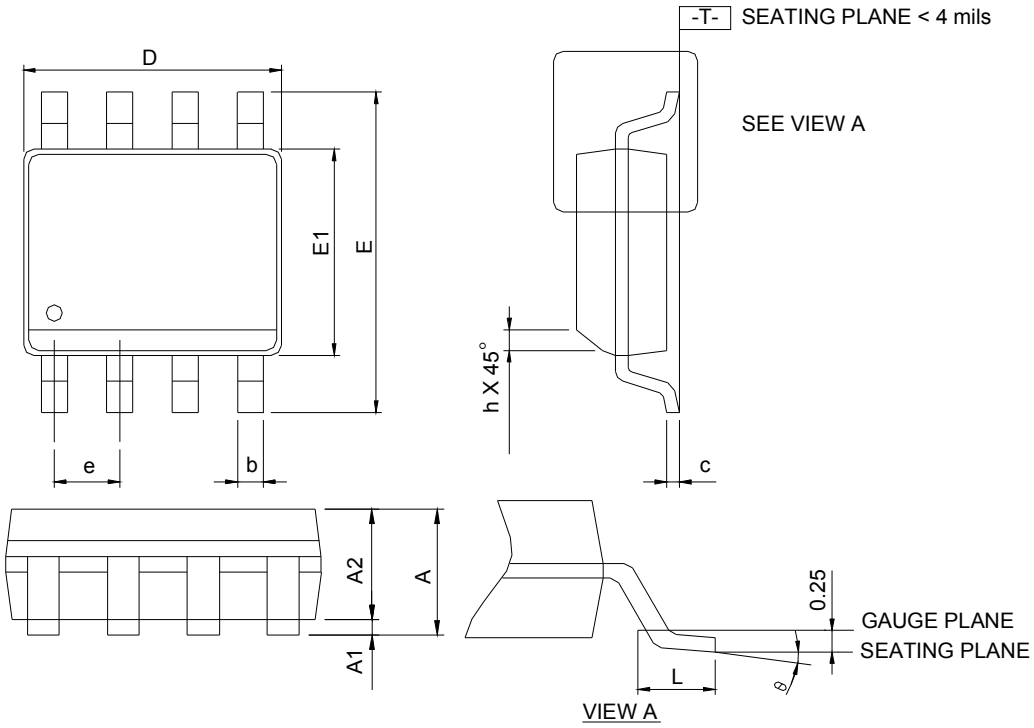
P Channel





Package Information

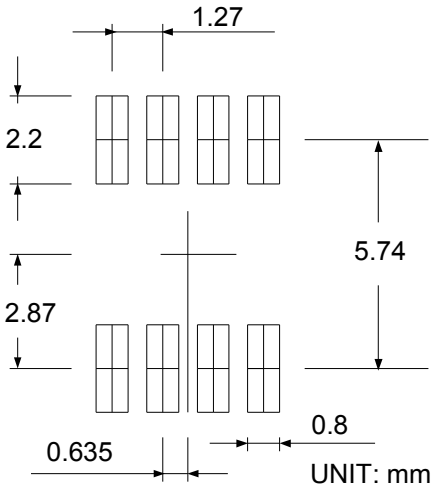
SOP-8



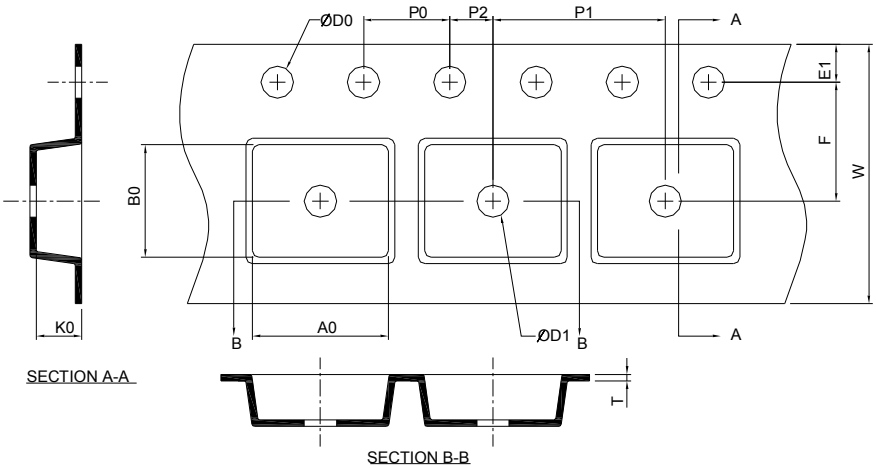
SYMBOL	SOP-8			
	MILLIMETERS		INCHES	
	MIN.	MAX.	MIN.	MAX.
A	-	1.75	-	0.069
A1	0.10	0.25	0.004	0.010
A2	1.25	-	0.049	-
b	0.31	0.51	0.012	0.020
c	0.17	0.25	0.007	0.010
D	4.80	5.00	0.189	0.197
E	5.80	6.20	0.228	0.244
E1	3.80	4.00	0.150	0.157
e	1.27 BSC		0.050 BSC	
h	0.25	0.50	0.010	0.020
L	0.40	1.27	0.016	0.050
θ	0°	8°	0°	8°

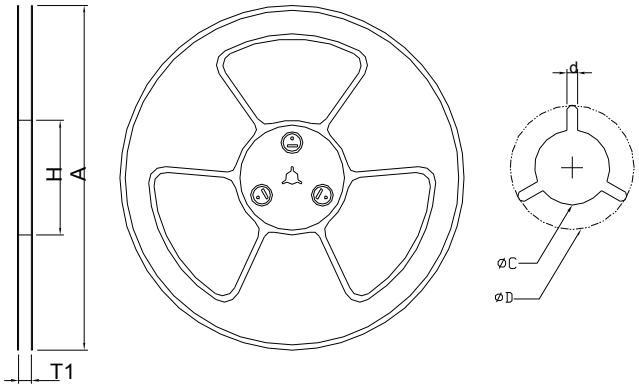
Note: 1. Follow JEDEC MS-012 AA.
2. Dimension “D” does not include mold flash, protrusions or gate burrs. Mold flash, protrusion or gate burrs shall not exceed 6 mil per side.
3. Dimension “E” does not include inter-lead flash or protrusions. Inter-lead flash and protrusions shall not exceed 10 mil per side.

RECOMMENDED LAND PATTERN



Carrier Tape & Reel Dimensions



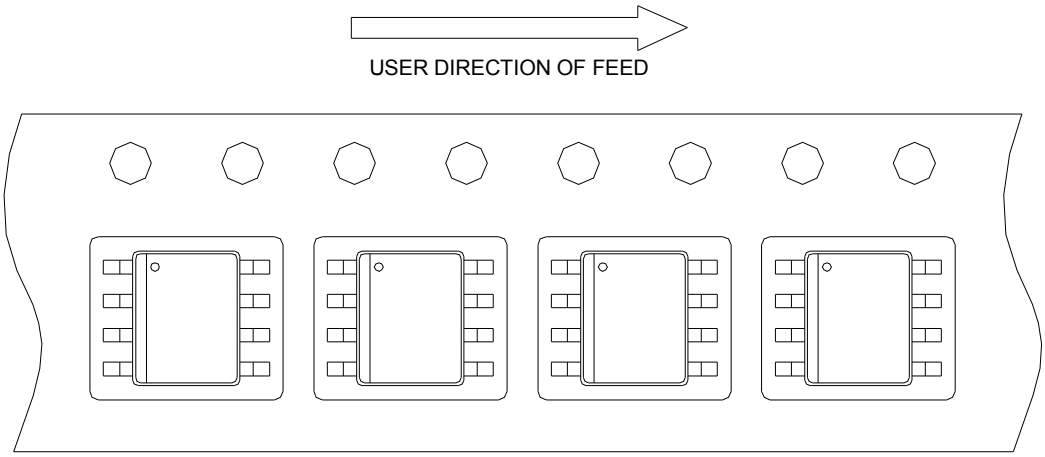


Application	A	H	T1	C	d	D	W	E1	F
SOP-8	330.0± 2.00	50 MIN.	12.4+2.00 -0.00	13.0+0.50 -0.20	1.5 MIN.	20.2 MIN.	12.0±0.30	1.75±0.10	5.5±0.05
	P0	**P1**	**P2**	**D0**	**D1**	**T**	**A0**	**B0**	**K0**
	4.0±0.10	8.0±0.10	2.0±0.05	1.5+0.10 -0.00	1.5 MIN.	0.6+0.00 -0.40	6.40±0.20	5.20±0.20	2.10±0.20

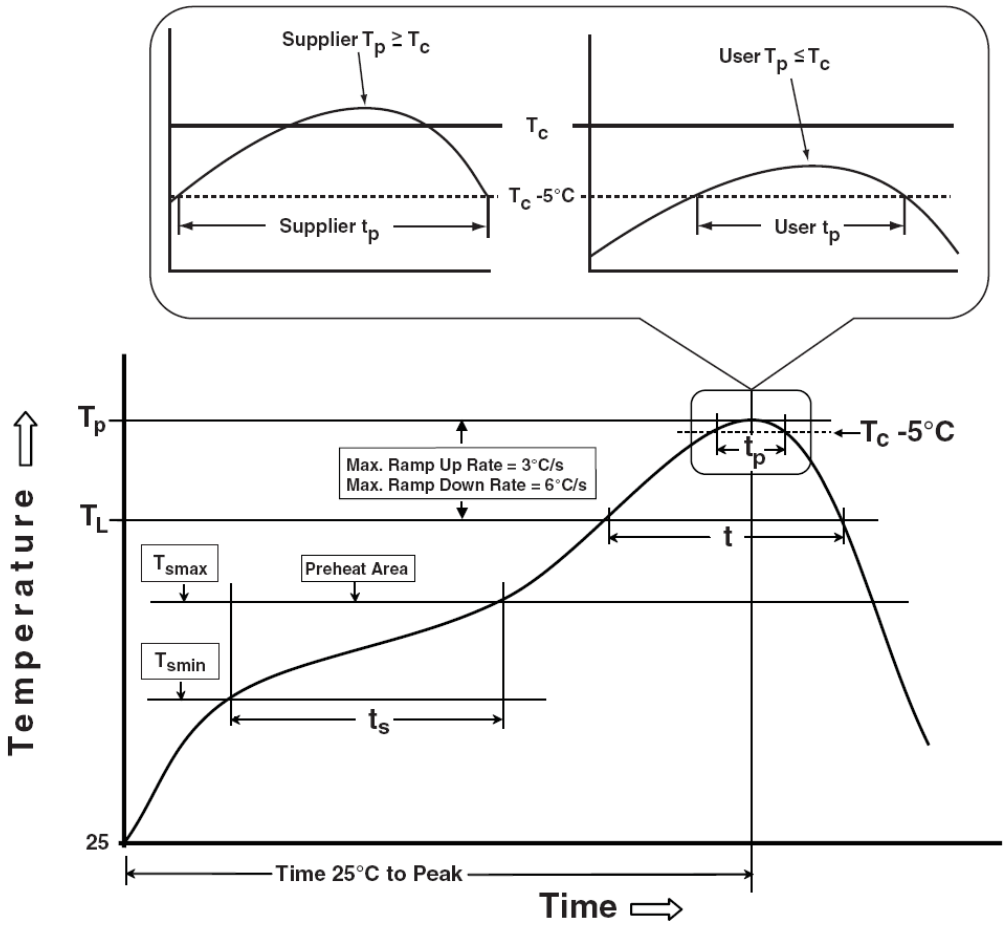
(mm)

Taping Direction Information

SOP-8



Classification Profile



Classification Reflow Profiles

Profile Feature	Sn-Pb Eutectic Assembly	Pb-Free Assembly
Preheat & Soak Temperature min (T_{smin}) Temperature max (T_{smax}) Time (T_{smin} to T_{smax}) (t_s)	100 °C 150 °C 60-120 seconds	150 °C 200 °C 60-120 seconds
Average ramp-up rate (T_{smax} to T_P)	3 °C/second max.	3°C/second max.
Liquidous temperature (T_L) Time at liquidous (t_L)	183 °C 60-150 seconds	217 °C 60-150 seconds
Peak package body Temperature (T_p)*	See Classification Temp in table 1	See Classification Temp in table 2
Time (t_P)** within 5°C of the specified classification temperature (T_c)	20** seconds	30** seconds
Average ramp-down rate (T_p to T_{smax})	6 °C/second max.	6 °C/second max.
Time 25°C to peak temperature	6 minutes max.	8 minutes max.
* Tolerance for peak profile Temperature (T_p) is defined as a supplier minimum and a user maximum. ** Tolerance for time at peak profile temperature (t_p) is defined as a supplier minimum and a user maximum.		

Table 1. SnPb Eutectic Process – Classification Temperatures (Tc)

Package Thickness	Volume mm^3 <350	Volume mm^3 ≥350
<2.5 mm	235 °C	220 °C
≥2.5 mm	220 °C	220 °C

Table 2. Pb-free Process – Classification Temperatures (Tc)

Package Thickness	Volume mm^3 <350	Volume mm^3 350-2000	Volume mm^3 >2000
<1.6 mm	260 °C	260 °C	260 °C
1.6 mm – 2.5 mm	260 °C	250 °C	245 °C
≥2.5 mm	250 °C	245 °C	245 °C

Reliability Test Program

Test item	Method	Description
SOLDERABILITY	JESD-22, B102	5 Sec, 245°C
HTRB	JESD-22, A108	1000 Hrs, 80% of VDS max @ Tjmax
HTGB	JESD-22, A108	1000 Hrs, 100% of VGS max @ Tjmax
PCT	JESD-22, A102	168 Hrs, 100%RH, 2atm, 121°C
TCT	JESD-22, A104	500 Cycles, -65°C~150°C

Customer Service

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